

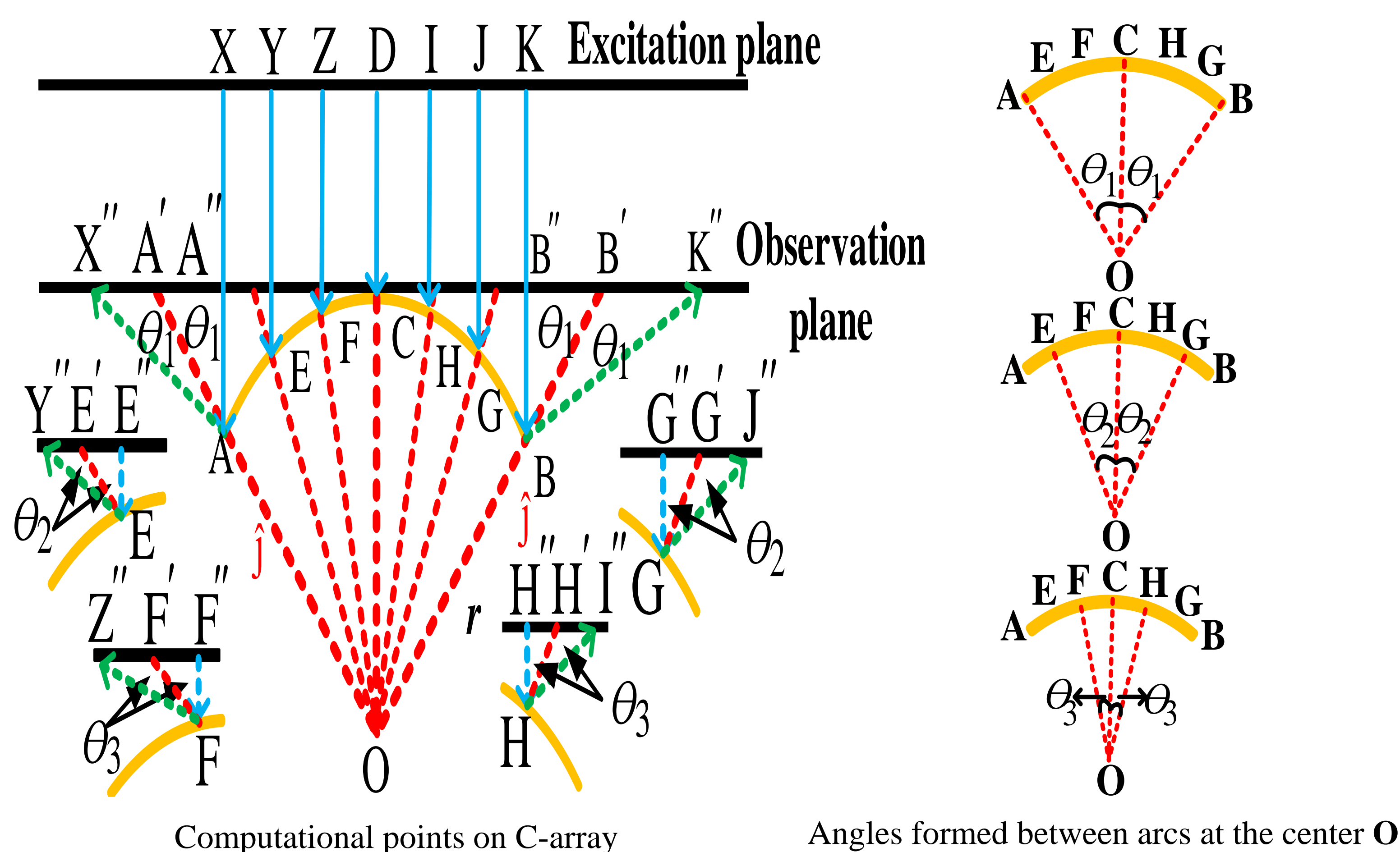
Abstract

- Shift in in-phase reflection frequency of conformal metasurface is determined with geometrical approach
- Analysis of the proposed approach is demonstrated for three types of conformal meta-surfaces
- Faster than full wave analysis to plot reflection phase of conformed meta-surfaces
- Model works equivalently well for both TE and TM mode of EM wave polarization
- The close agreement of measured and calculated reflection phases validates the accuracy of the proposed geometrical approach

Introduction

- In-phase (0°) reflection phase of meta-surface enhances radiation properties of antenna.
- The incident and reflected waves meets constructively at the far-field for antenna incorporated with metasurface ground plane.
- Conformability (bendability), an essential attribute of body worn antennas necessitate design of conformal meta-surfaces \rightarrow shift in in-phase reflection frequency \rightarrow degradation of antenna performance
- Large meta-surfaces are possible solution to cover the intended band even after bending \rightarrow overall increased size of antenna \rightarrow inconsistent with body worn device standards
- Present analytical solutions are complex and works for large antenna arrays
- Proposed approach works well on smaller meta-surface cells and arrays

Proposed Geometrical Approach for Arrays



Law of Reflection of EM wave at the points: A – B, E – G, F – H

$$\begin{aligned} \angle A'AX'' &= \angle A''AA' = \angle B'BK'' = \angle B''BB' = \theta_1 \\ \angle E'EY'' &= \angle E''EE' = \angle G'GJ'' = \angle G''GG' = \theta_2 \\ \angle F'FZ'' &= \angle F''FF' = \angle H'HI'' = \angle H''HH' = \theta_3 \end{aligned}$$

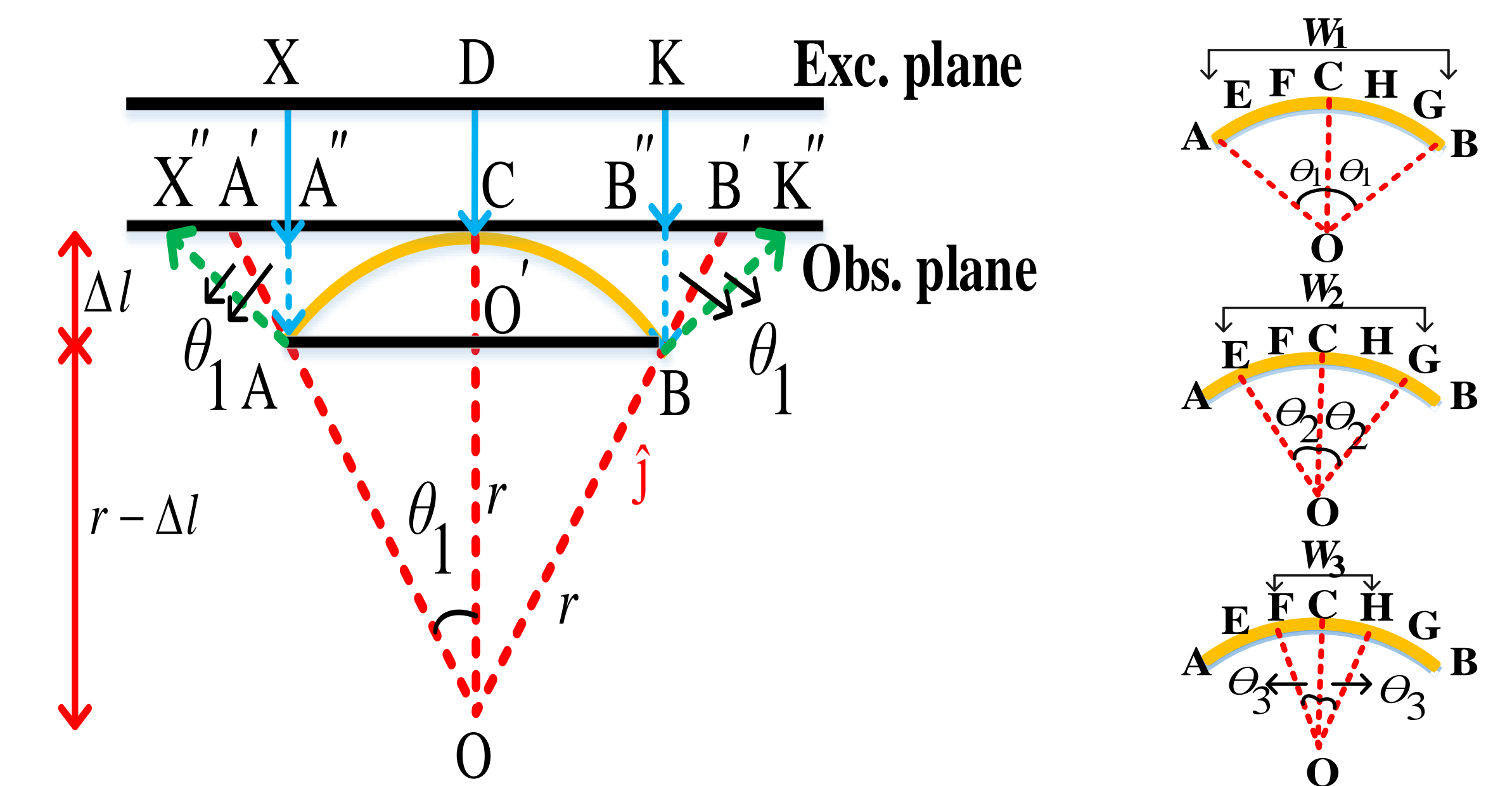
Formula for $\theta_1, \theta_2,$ and θ_3 and Path Delays $\Delta l_1, \Delta l_2,$ and Δl_3

$$W_j = \frac{2\theta_m}{360^\circ} \times 2\pi r \quad \rightarrow \quad 2\theta_m = \frac{W_j \times 360^\circ}{2\pi r} \quad (m, j = 1 \dots 3)$$

$$\Delta\theta_{\text{incident}} = \beta \times (A''A) = \beta\Delta l \quad \Delta\theta_{\text{reflected}} = \beta \times AX''$$

$$\cos(\angle X''AA'') = \cos 2\theta_1 = \frac{\Delta l}{AX''} \quad \rightarrow \quad AX'' = \frac{\Delta l}{\cos 2\theta_1}$$

Proposed Geometrical Approach for Arrays



$$\cos \theta_1 = \frac{OO'}{OA} = \frac{r - \Delta l}{r} \quad \rightarrow \quad \Delta l = r - r \cos \theta_1$$

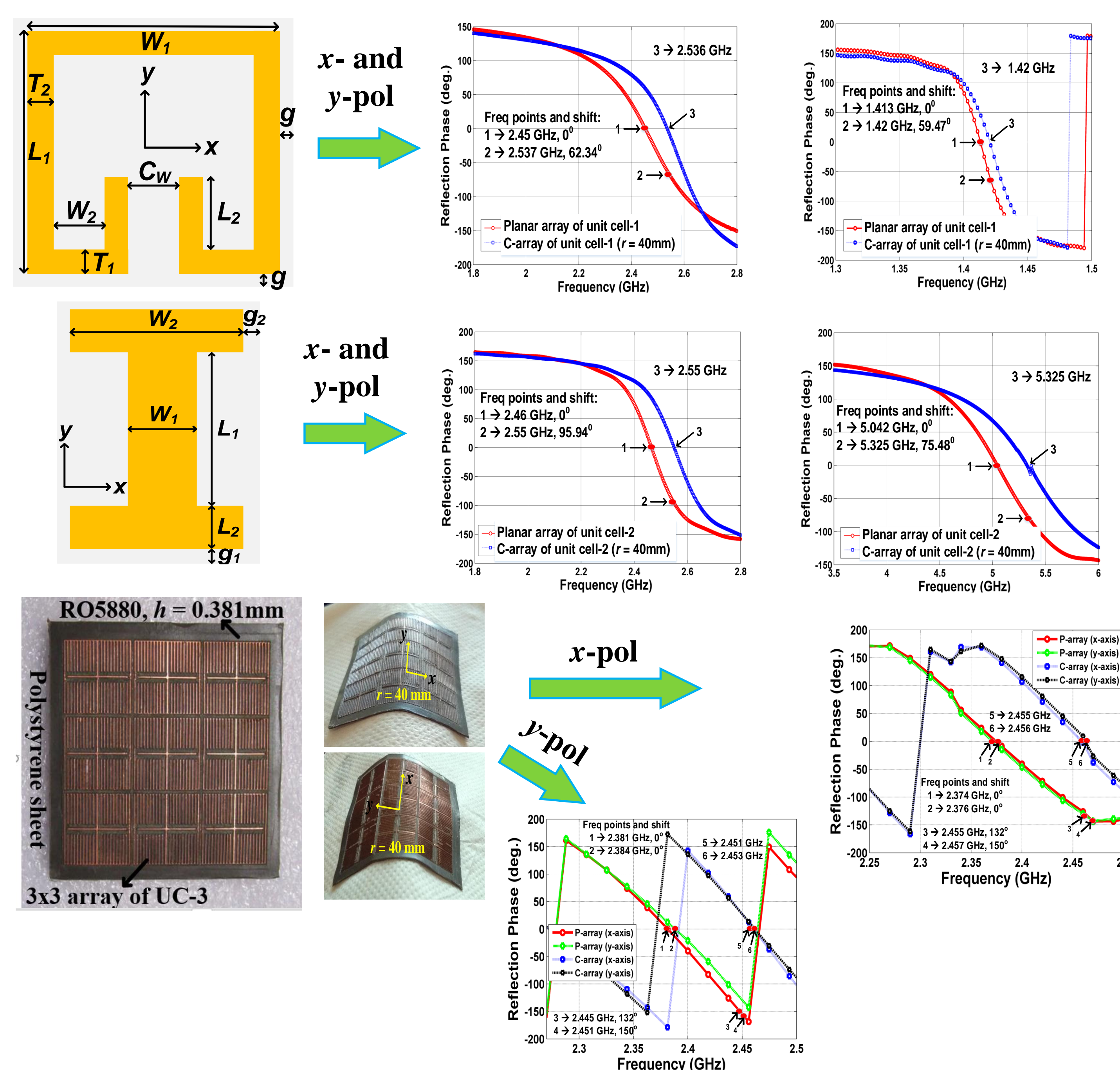
$$\Delta l_k = r - r \cos \theta_m \quad (k, m = 1 \dots 3)$$

Formula for θ_{shift}

$$\theta_{\text{shift}} = 2 \cdot \left(\begin{aligned} &\Delta\theta_{\text{in}}|_A + \Delta\theta_{\text{in}}|_E + \Delta\theta_{\text{in}}|_F + \\ &\Delta\theta_{\text{ref}}|_A + \Delta\theta_{\text{ref}}|_E + \Delta\theta_{\text{ref}}|_F \end{aligned} \right)$$

$$\theta_{\text{shift}} = 2 \cdot \left(\begin{aligned} &\beta\Delta l_1 + \beta\Delta l_2 + \beta\Delta l_3 + \\ &\frac{\beta\Delta l_1}{\cos 2\theta_1} + \frac{\beta\Delta l_2}{\cos 2\theta_2} + \frac{\beta\Delta l_3}{\cos 2\theta_3} \end{aligned} \right)$$

Theoretical, Simulation and Measured Results



Conclusion

- Geometrical approach to determine shift in the reflection phase of conformal array is proposed
- Proposed technique makes use of the law of reflection of EM wave at the interface
- Technique is applicable for both the polarization of EM wave i.e. x- and y- and TE and TM polarized waves
- Simulated, theoretical and measured results are in good agreement

REFERENCES

- [1] D Rano and MS Hashmi, "Interdigital based EBG: compact and Polarization stable for MBAN and Wi-Fi" in *Proc. EuCAP*, London, UK, 2018, pp. 1–5.
- [2] D Rano and MS Hashmi, "Extremely compact EBG-backed antenna for smart-watch applications in medical body area network," *IET Microwave. Antennas Propag.* 2019, 13, 1031–1040.
- [3] M Abbasi, et. Al. "Compact EBG-backed planar monopoles for BAN wearable applications," *IEEE Trans. Ant. Prop.*, 2016, 65, 453–463.
- [4] D. Sievenpiper, "Circuit and method for eliminating surface currents on metals," U.S. Patent 60/079953, 30, 1998.
- [5] F. Yang, et al., *Electromagnetic Band Gap structures in Antenna Engineering*. New York, NY, USA: Cambridge Univ. Press, 2009.